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		V		U.S. PATENT DOCUMENTS		- (-			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS		DATE OPRIATE)	
DOK	1	5192371	03/09/93	Shuto, et al.					
UK	2	5571330	11/05/96	Kyogoku		A	) <u> </u>		
TOK	3	5976312	11/02/99	Shimizu, et al.		4			
XK	4	6053686	04/25/00	Kyogoku		00		10	
DIK	5	6063203	05/16/00	Satoh		RO.	18.	SA	
TIL	6	6113704	09/05/00	Satoh, et al.			7 8 700 10 300	2	
TOK	7	6120605	09/19/00	Sato		Ĭ	Sol	•	
SIK	8	6154301	11/28/00	Harvey			- V	0	
MK	9	6193803	02/27/01	Sato, et al.					
TOL	10	6305898	10/23/01	Yamagishi, et al.					
TOP	11	6488775	12/03/02	Shimizu, et al.					
				FOREIGN PATENT DOCUMENTS					
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EXAMINER D. VIAMINE DATE CONSIDERED 8-25-03

\*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609, DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.